

The reality of Mirrors?

GWADW May 15, 2012

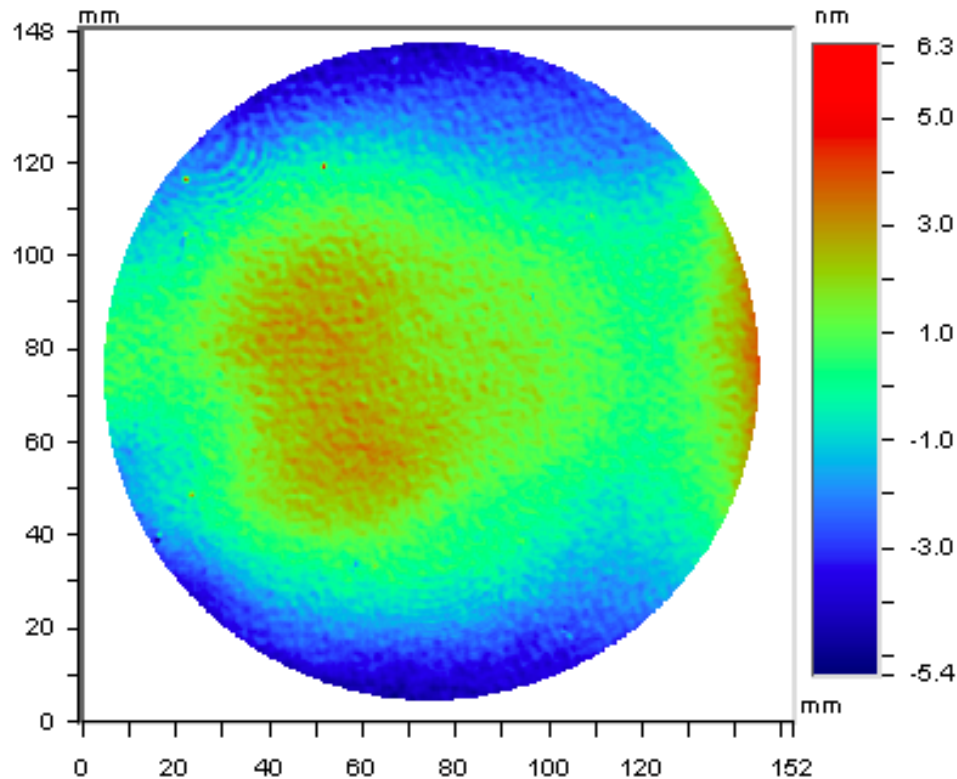
GariLynn Billingsley
Liyuan Zhang
Zygo...
CSIRO...



Overview

- Initial LIGO
 - » Some things we got wrong
- Advanced LIGO
 - » Some things we got right
 - » Some things we're still working on
- Next Generation
 - » Tools we have on hand

Error in iLIGO calibration file

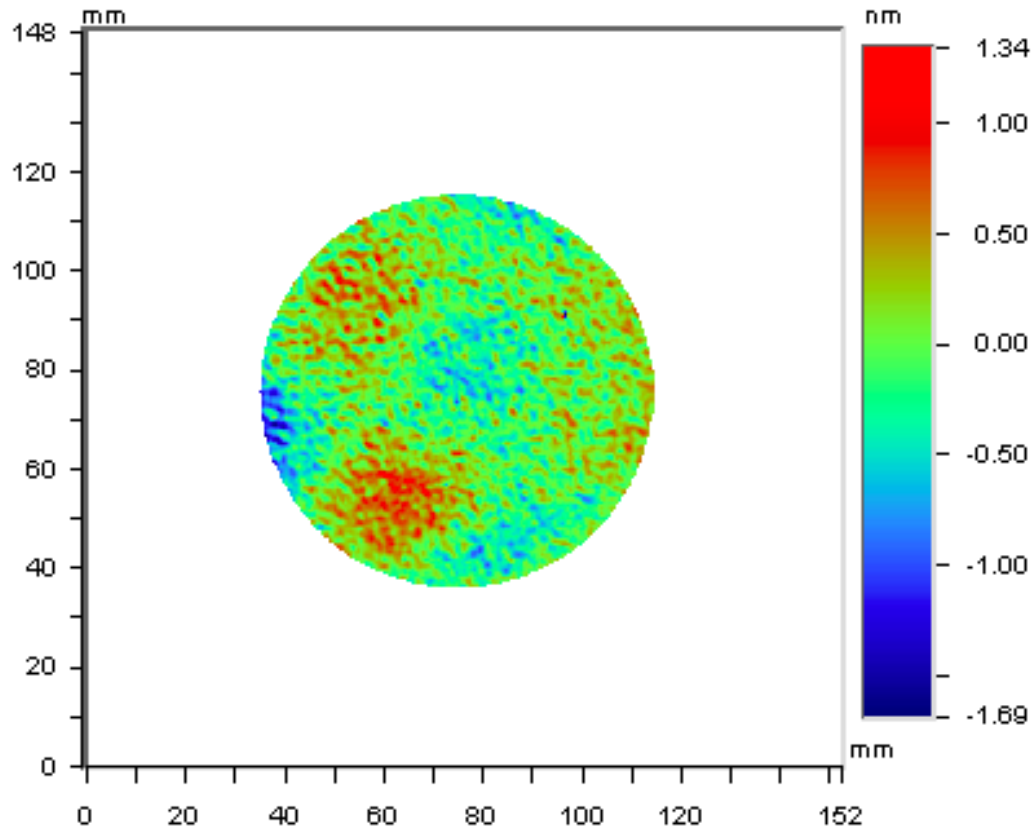


11.7 nm PV over 150mm, Mostly power,
The instrument has been realigned, so the original error may be different

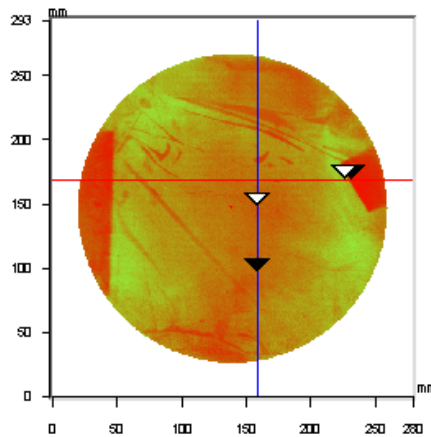
LIGO Power subtracted, analyzed over beam size

Rms = 0.35 nm

ILIGO
Optic figure is
Still better than
iLIGO metrology

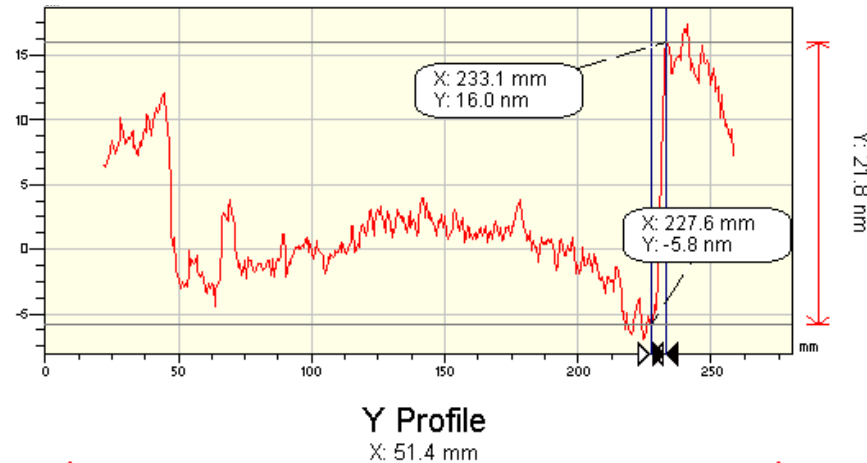


iLIGO too much cleaning before coating extreme example ~20 nm

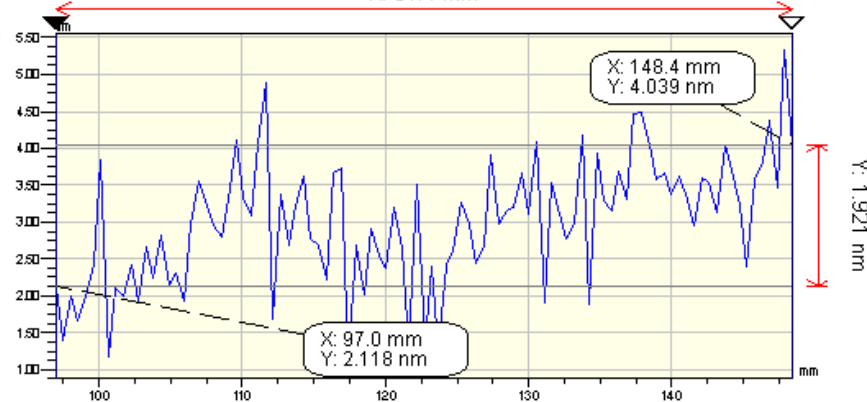


X	159.16	-	-	mm
Y	168.57	-	-	mm
Ht	0.81	-	-	nm
Dist		-	-	mm
Angle		-	-	°

Title: 4ITM01 side 1



**Microroughness
was also
Measured**

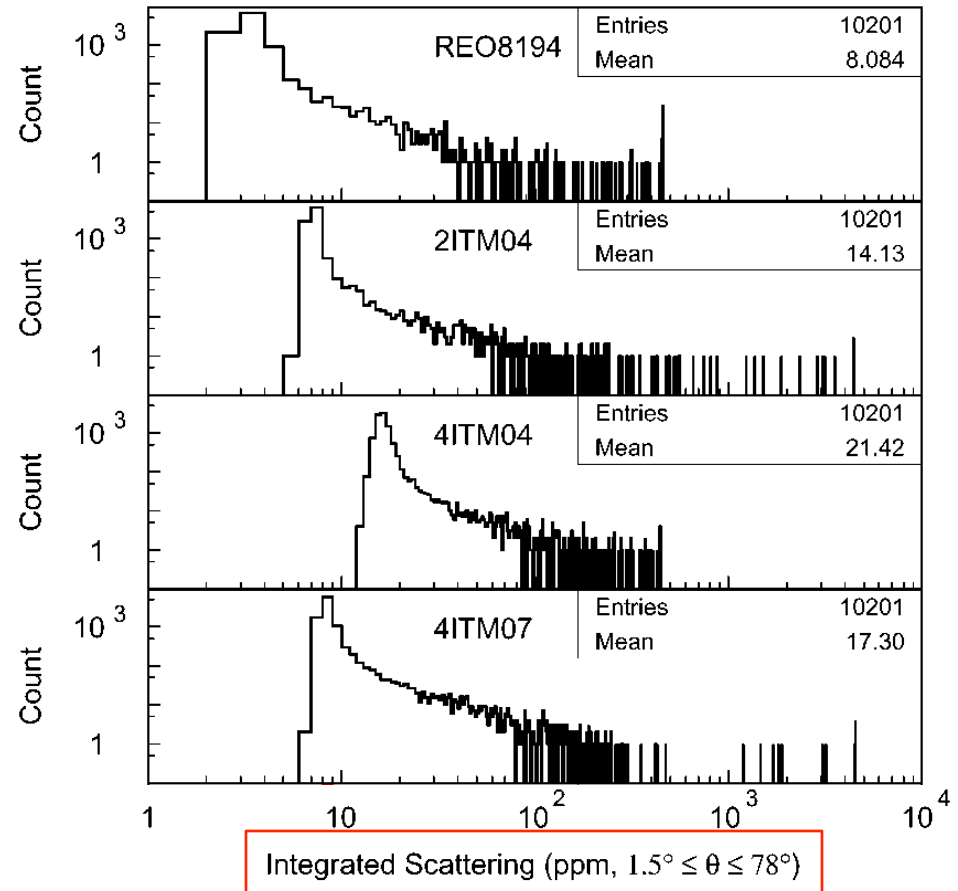


**Before : 0.26 nm rms
After : 0.72 nm rms**

Scatter histograms

An indication of etching

- Lower end represents the base microroughness
- High end represents point defects
- See LIGO-G080162 for details





Advanced LIGO

- Status
- Capability
- Interesting coating behavior
 - » Still in the speculation phase

aLIGO Arm Cavity Loss:

Early results are in line with budget

Cavity loss – 2 surfaces (ppm)	Budget 2010 based on specs (ppm)	Actuals 2012 based on (n of 20) (ppm)
Microroughness scatter	8	2.2 (avg. of 20)
Defects (Polish, Coating, Contamination)	26	15 (sample of 2) pol, coat
Coating Absorption*	0.6	0.6 (sample of 2)
Surface Figure Error & Diffraction	24	3 ppm on coated ITM 21 ppm estimated on coated ETM
ETM Transmission	5	No data yet
Total (required < 75 ppm)	64	42+ ETM trans.

50ppm budget remaining for contamination and coating induced surface figure error.

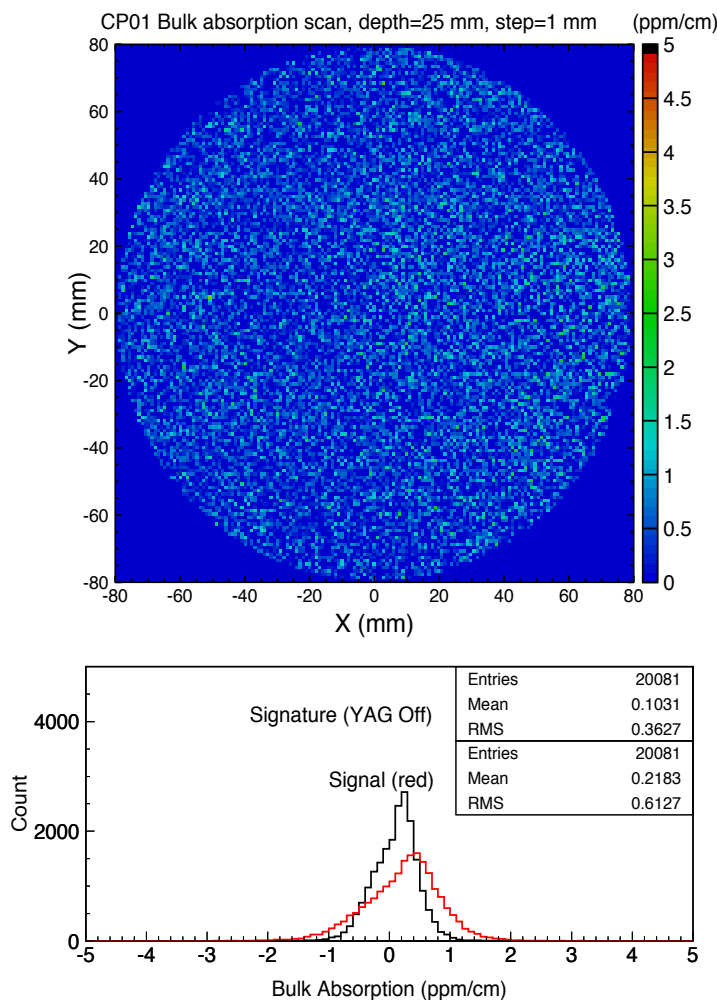
* One TM trial surface had unexplained high absorption – no cause has been identified, no repeat of the problem

Quick summary of aLIGO ITM polish

Serial Number	ROC	Figure (-TPA)
ITM01	1939.32	0.10
ITM03	1939.52	0.08
ITM04	1938.61	0.15
ITM05	1939.18	0.10
ITM06	1937.60	0.09
ITM07	1938.53	0.10
ITM08	1938.44	0.16
ITM09	1938.15	0.11
ITM10	1938.15	0.14
ITM11	1939.39	0.18

Follow our progress at <https://nebula.ligo.caltech.edu/optics/>

Heraeus 3000 series Suprasil measurable absorption?

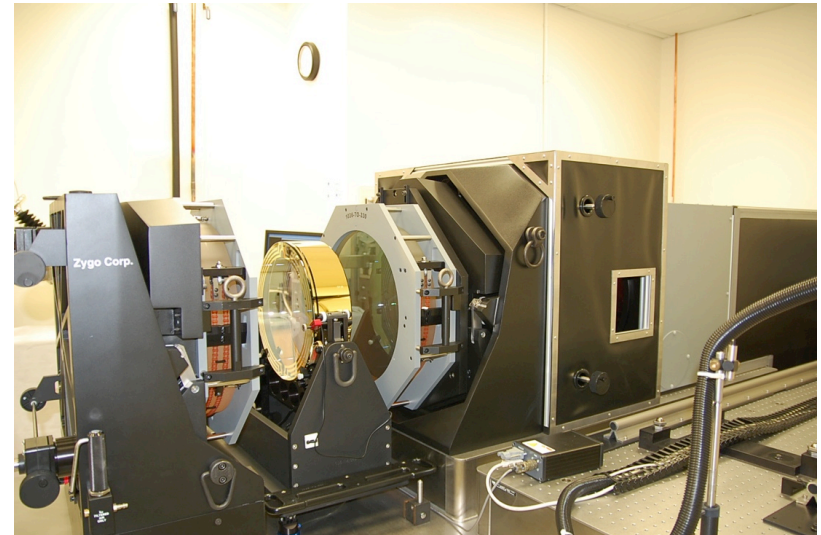


OH content for 3000 series is 100 times lower than for the 300 series glass

Signal (red): 0.21 ppm
Background: 0.10 ppm

Metrology

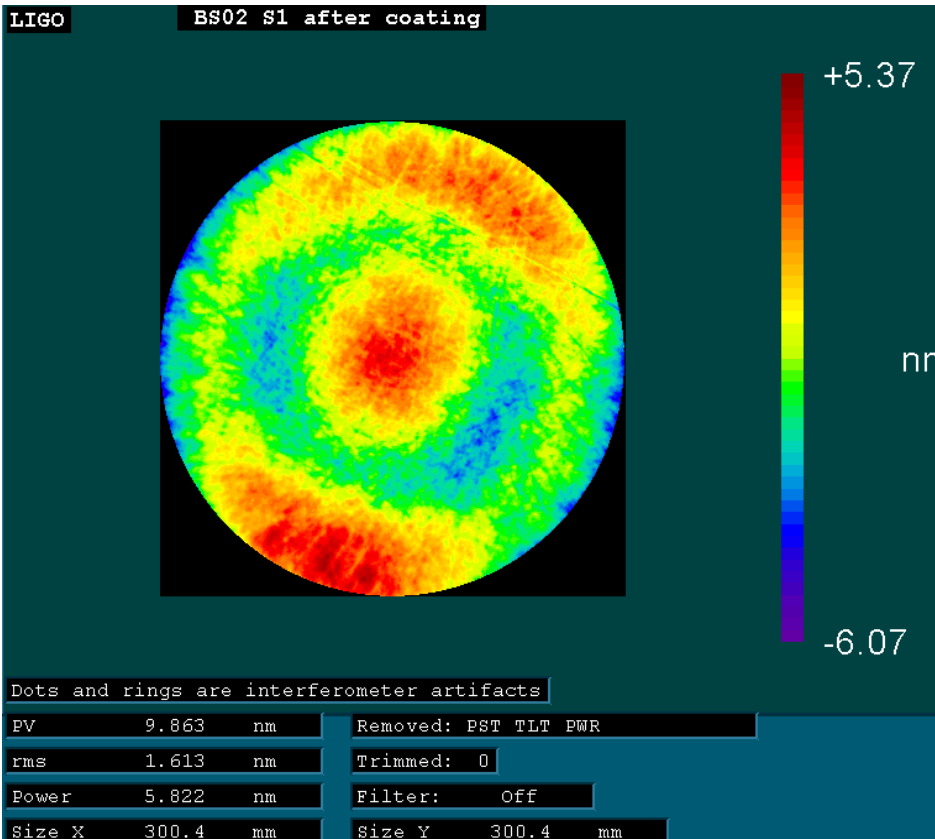
- Zygo full aperture interferometer is installed and operating at Caltech
- All metrology flats and spheres are complete
- The instrument and environment are quite stable, showing a uniform noise floor of 0.1 to 0.15 nm rms.
 - » Polishing requirement is 0.3 nm rms
 - » Vendor reports some surfaces at 0.08 nm rms
- Good agreement with Polishing vendor measurements



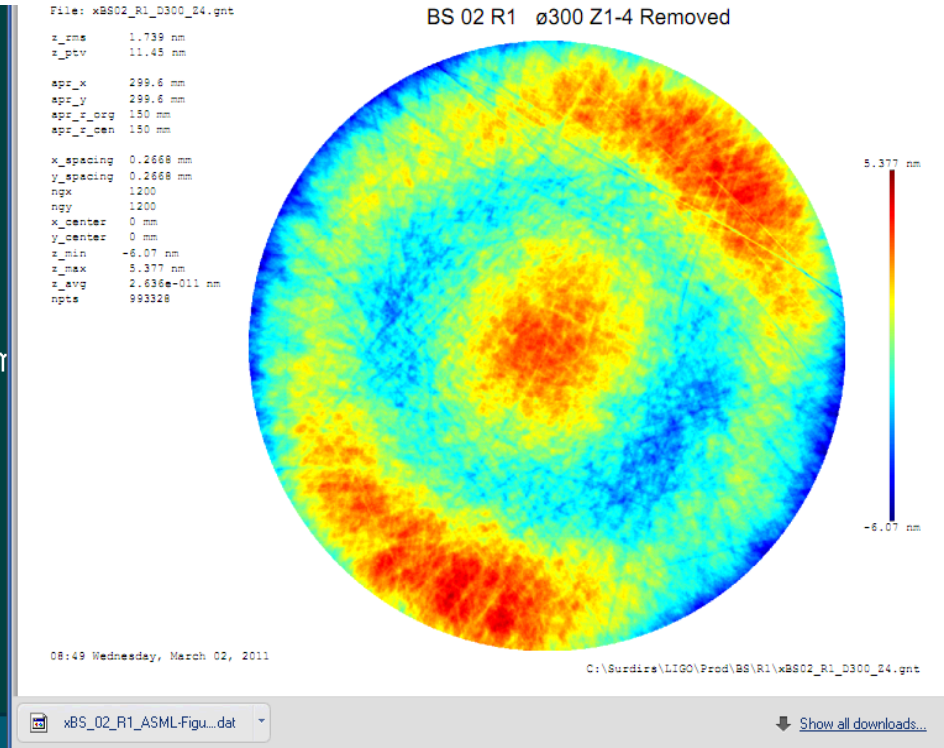
LIGO Figure, before and after coating measured on different instruments

Same diameter same color scale

LIGO measurement after coating by CSIRO
9.8 nm PV 1.6 nm rms



Polisher (Zygo EPO) measurement
11.4 nm PV 1.7 nm rms

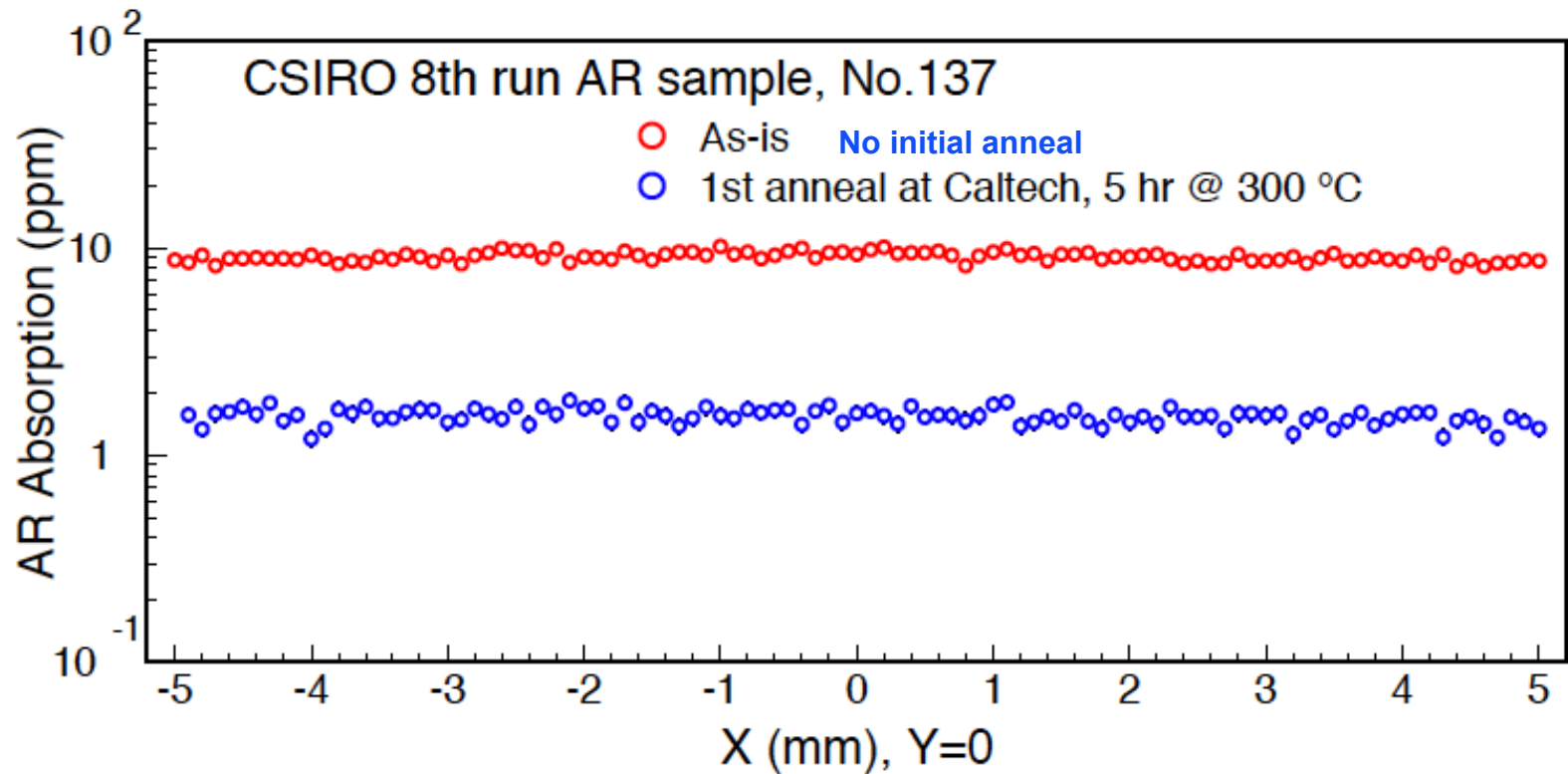


AR coating absorption surprise

- AR coating absorption is not the same as HR
 - » Most IBS HR absorption is now < 1 ppm, AR up to 10 ppm
- Many samples used to explore the parameters
 - » Film thickness – thinner is more sensitive to annealing temp
 - » Annealing temperature – sensitive to 25 C° variations
- Unintentional experiment:
 - » ~1nm of Silica added to top Silica layer AFTER the initial 400 C anneal (to tune reflectivity)
 - » Second anneal at 300 C° → Absorption of 4 ppm
 - » Third anneal at 400 C → Absorption < 0.5 ppm

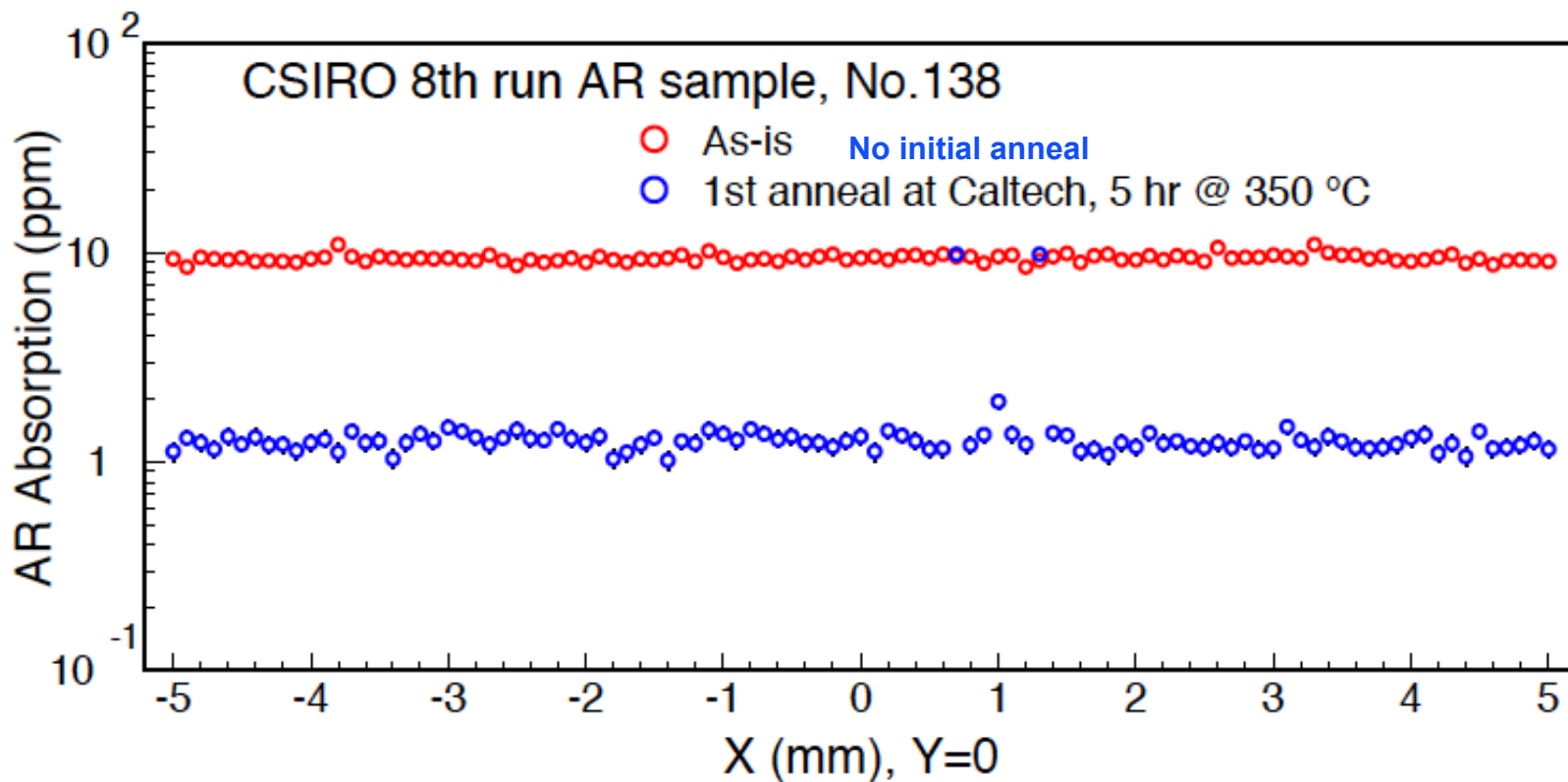
AR Absorption – 300 C°

Too much absorption



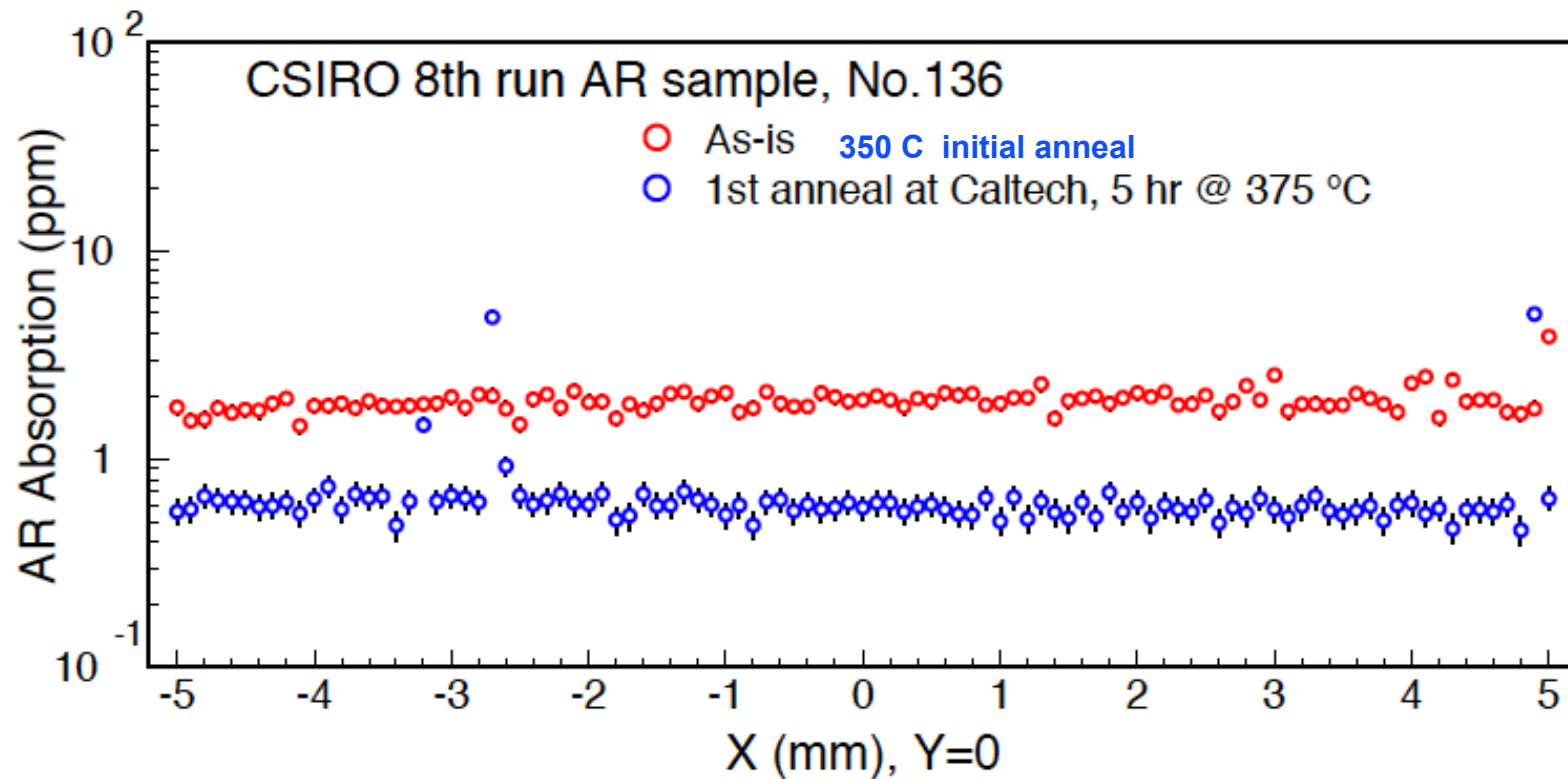
Absorption of CSIRO AR test sample Measured by Zhang at Caltech
Design < 1/20 wave Tantalum + 1/4 wave Silica

AR Absorption – 350 C° still too much absorption



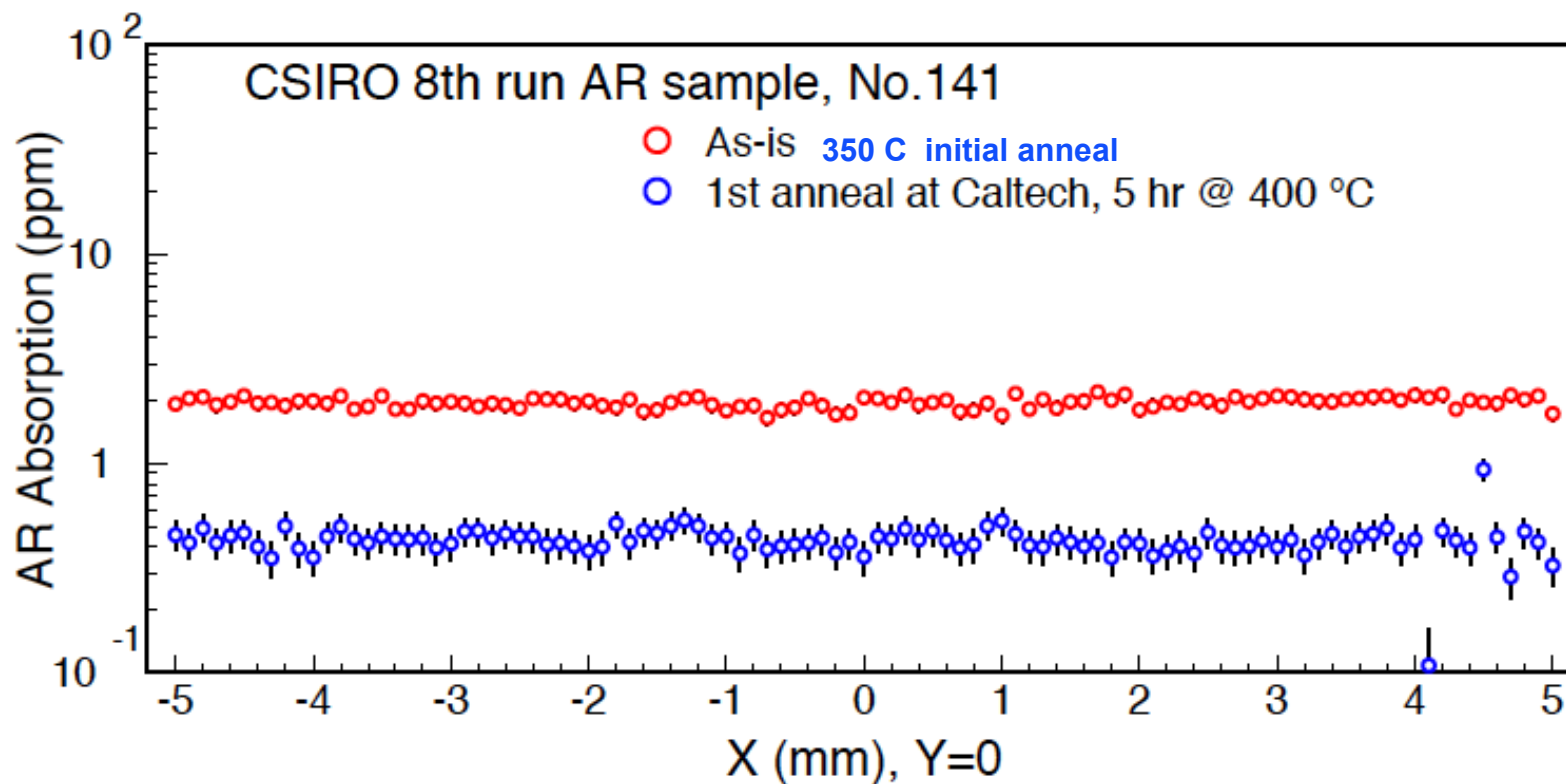
Absorption of CSIRO AR test sample Measured by Zhang at Caltech
Design < 1/20 wave Tantalum + 1/4 wave Silica

AR Absorption – 375 C° better



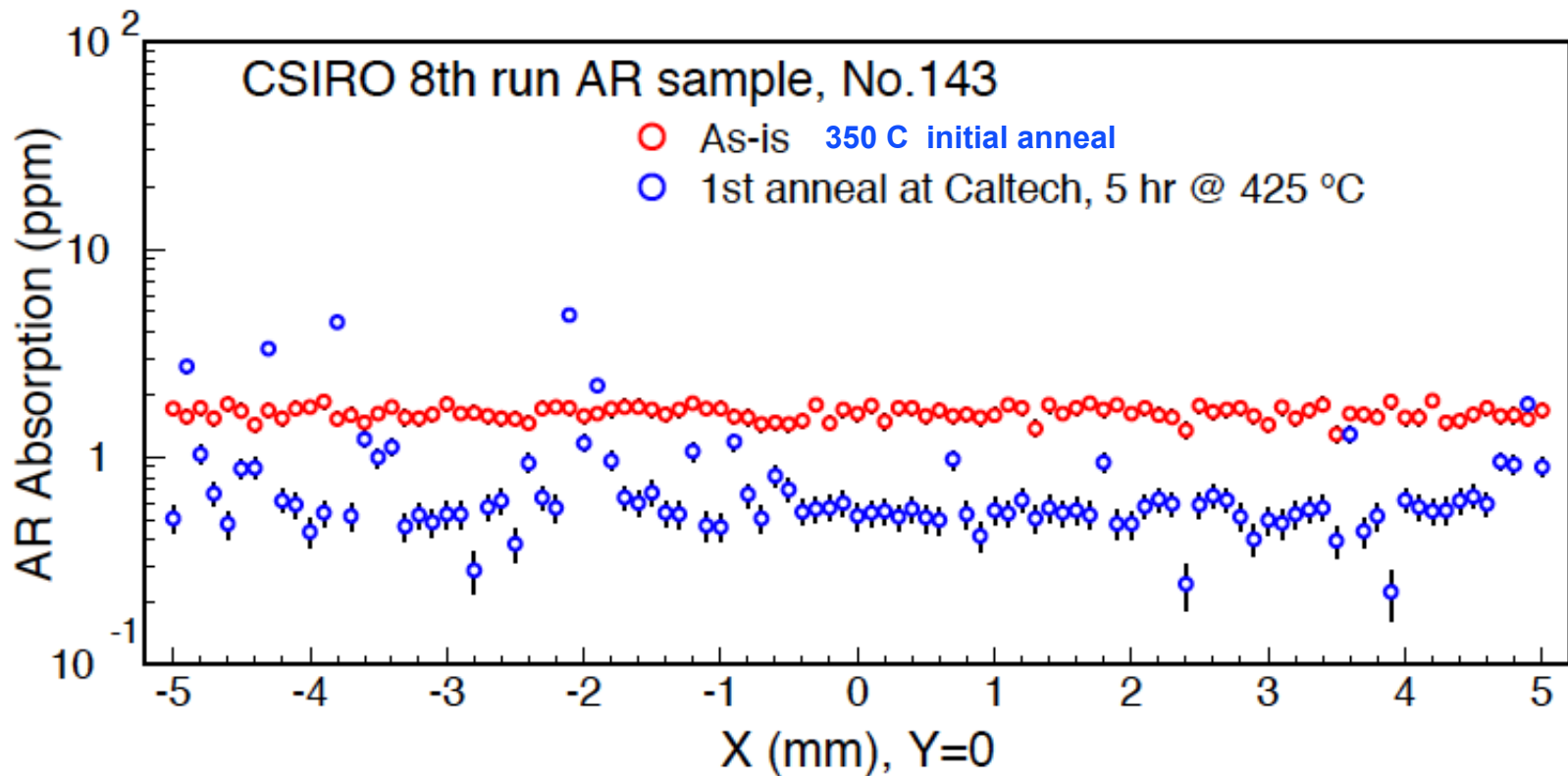
Absorption of CSIRO AR test sample Measured by Zhang at Caltech
Design < 1/20 wave Tantalum + 1/4 wave Silica

AR Absorption – 400 C° even better



Absorption of CSIRO AR test sample Measured by Zhang at Caltech
Design < 1/20 wave Tantara + ¼ wave Silica

AR Absorption – 425 C° too far!



Absorption of CSIRO AR test sample Measured by Zhang at Caltech
Design < 1/20 wave Tantara + 1/4 wave Silica

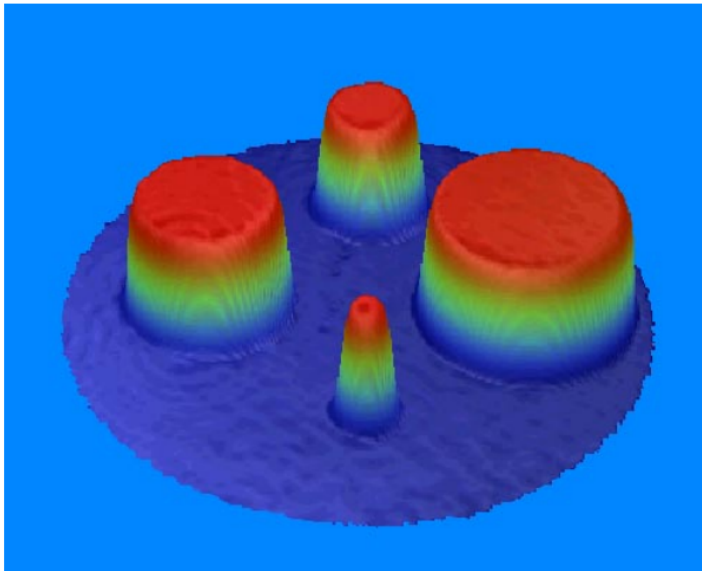


Next generation

- Thinking about non-spherical surfaces

Future – sculpt your own surface

- Difference from a sphere
 - » < 100 nm in any area where scatter loss is important
 - » Surface slope up to ~ 20 nm/mm
 - » Current vendors can't handle much larger optics
- Ion beam figuring can sculpt silicon as well as silica... others.



**This data is inverted for display,
ion beams removed material**

Data and demonstration by CSIRO

LIGO Correcting inhomogeneity of Heraeus 3001 by Ion beam figuring of side 2

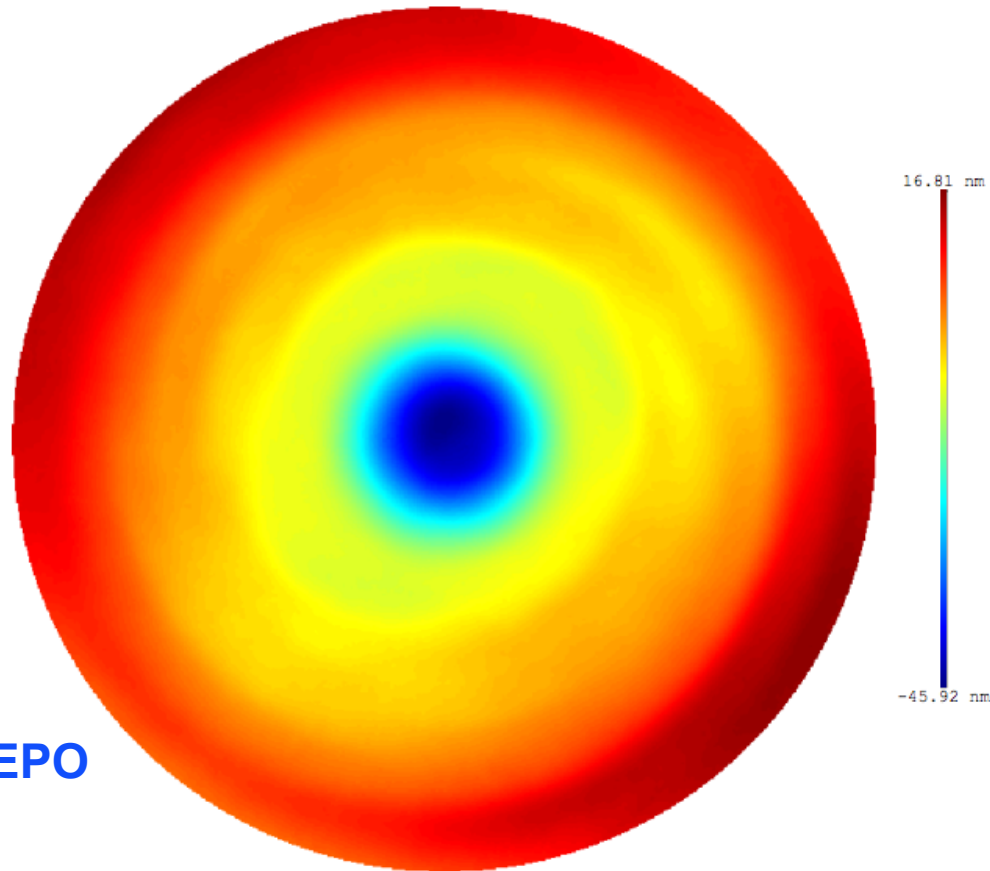
File: xCP08_R2_D160_Z3.gnt

CP 08 R2 ø160 Z1-3 Removed

z_rms 10.36 nm
z_ptv 62.72 nm

apr_x 159.9 mm
apr_y 159.9 mm
apr_r_org 80 mm
apr_r_cen 80 mm

x_spacing 0.2669 mm
y_spacing 0.2669 mm
ngx 1200
ngy 1200
x_center 0 mm
y_center 0 mm
z_min -45.92 nm
z_max 16.81 nm
z_avg -6.738e-012 nm
npts 282192



PV= 63 nm

Data and work by Zygo EPO

Resulting Transmitted wavefront Corrected s2 plus bulk

File: xCP08_Single_Pass_TWE_D160_Z6.gnt

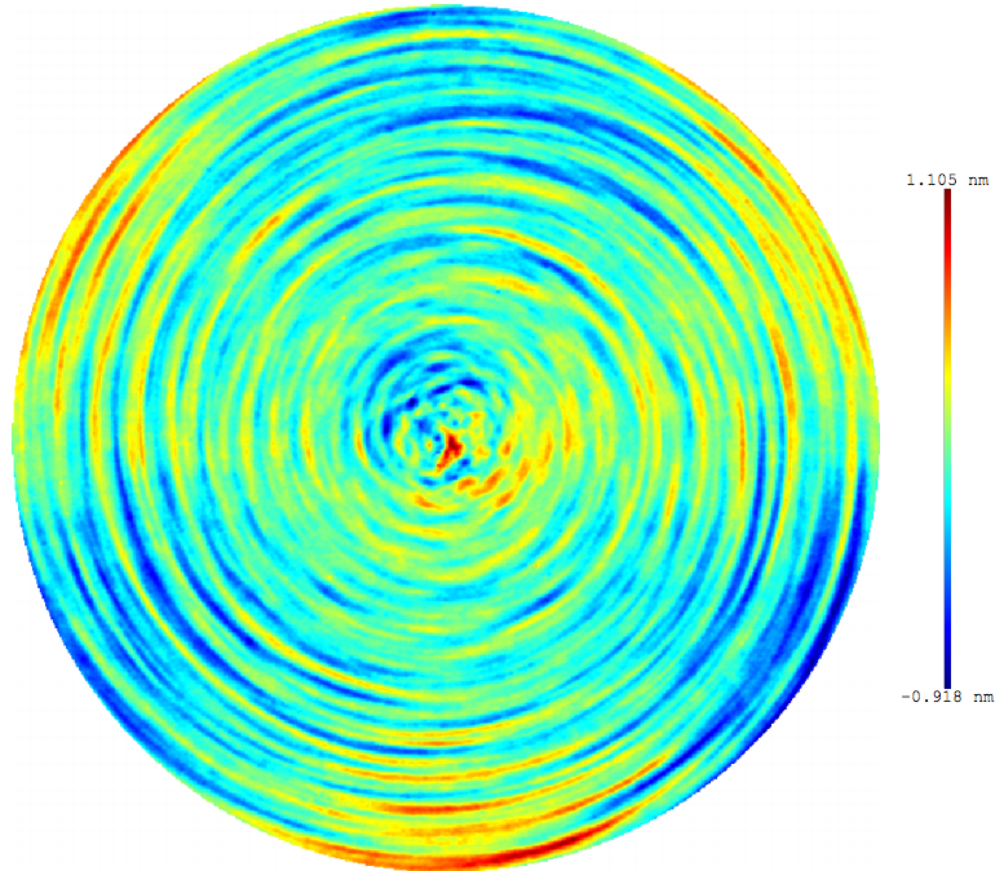
CP 08 Single Pass TWE ø160 Z1-6 Removed

```

z_rms      0.2415 nm
z_ptv      2.023 nm

apr_x      159.9 mm
apr_y      159.9 mm
apr_r_org  80 mm
apr_r_cen  80 mm

x_spacing  0.2669 mm
y_spacing  0.2669 mm
ngx        1200
ngy        1200
x_center   0 mm
y_center   0 mm
z_min      -0.918 nm
z_max      1.105 nm
z_avg      -1.035e-011 nm
npts       282192
    
```



PV= 2 nm
rms = 0.24 nm
Data and work by
Zygo EPO

Summary

- Part per million losses matter!!!
- We know a lot more about cleaning and metrology
- We are well positioned to handle an optical upgrade as long as the test mass size does not increase dramatically